



CXL1503M/1505M

CMOS-CCD Signal Processor

Description

CXL1503M/1505M are CMOS-CCD signal processors developed for CCD camera complementary color filter array processing system.

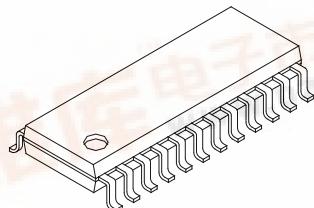
CXL1503M 1H × 4 301.5 bit CCD delay line

CXL1505M 1H × 4 453.5 bit CCD delay line

Features

- Single power supply 5V
- Low power consumption
CXL1503M 100mW (Typ.)
CXL1505M 150mW (Typ.)
- Built-in peripheral circuits
- Built-in CDS (Correlated Double Sampling) circuit

24 pin SOP (Plastic)



Function

- Clock driver
- Autobias circuit (center and black)
- Pedestal clamp circuit
- CDS circuit

Structure

CMOS-CCD

Absolute Maximum Ratings (Ta = 25°C)

- Supply voltage V_{DD} 6 V
- Operating temperature Topr -10 to +60 °C
- Storage temperature T_{stg} -55 to +150 °C
- Allowable power dissipation P_D 500 mW

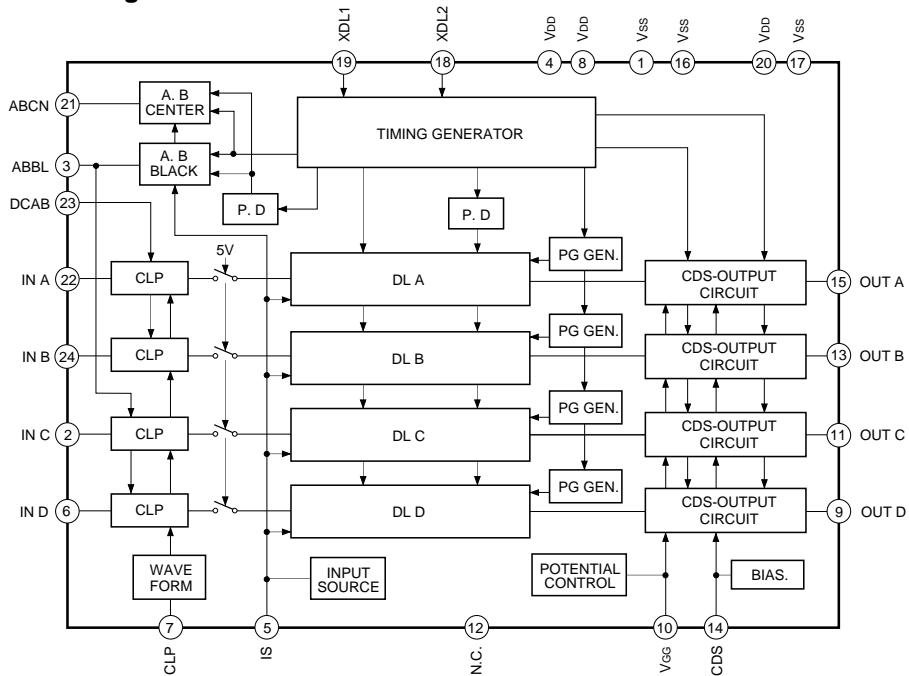
Recommended Operating Conditions (Ta = 25°C)

Supply voltage V_{DD} 5 ± 5% V

Recommended Clock Conditions (Ta = 25°C)

Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Clock voltage Low	V _L	0		1.0	V	
Clock voltage High	V _H	V _{DD} - 1.0		V _{DD}	V	
Clock frequency	CXL1503M	f _{CL}	4.77		MHz	NTSC: 910f _H /3 CCIR: 908f _H /3
	CXL1505M	f _{CL}	7.16		MHz	NTSC: 455f _H CCIR: 454f _H

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Block Diagram**Pin Configuration (Top View)****Pin Description**

No.	Symbol	I/O	Description	Impedance (Ω)
1, 16, 17	Vss	—	GND	
2	IN C	I	Signal input C channel	> 100k (at no clamp)
3	ABBL	O	Autobias DC output for Y signal	2k to 20k
4, 8, 20	Vdd	—	5V power supply	
5	IS	O	Input source DC output	5k
6	IN D	I	Signal input D channel	> 100k (at no clamp)
7	CLP	I	Clamp pulse input	> 100k
9	OUT D	O	Signal output D channel	50 to 500
10	Vgg	O	Gate bias DC output	2k to 10k
11	OUT C	O	Signal output C channel	50 to 500
12	N.C.	—	—	
13	OUT B	O	Signal output B channel	50 to 500
14	CDS	O	DC output for CDS	500 to 5k
15	OUT A	O	Signal output A channel	50 to 500
18	XDL2	I	Clock pulse input 2	> 100k
19	XDL1	I	Clock pulse input 1	> 100k
21	ABCN	O	Autobias DC output for C signal	2k to 20k
22	IN A	I	Signal input A channel	> 100k (at no clamp)
23	DCAB	I	DC bias input for A and B channel	> 100k
24	IN B	I	Signal input B channel	> 100k (at no clamp)

Electrical Characteristics

SONY

CXL1503M/1505M

($T_a = 25^\circ\text{C}$, $V_{DD} = 5.0\text{V}$, $V_{SS} = 0\text{V}$) $f_{CL} = 4.77\text{MHz}$ (CXL1503M)
 $f_{CL} = 7.16\text{MHz}$ (CXL1505M)

Item	Symbol	Test Point	SW position				Bias condition	Conditions			Min.	Typ.	Max.	Unit
			SW1	SW2	SW3	SW4 to 7		E1						
Autobias center level	ABCN	V_1	a	b	a	a					1.0	2.0	4.0	V
Autobias black level	ABBL	V_2	a	b	a	a					1.2	2.2	4.2	V
Input source level	IS	V_3	a	a	a	a					0.3	0.6	3.0	V
CDS source level	CDS	V_4	a	a	a	a					1.2	2.3	3.5	V
Output circuit bias level	V_{GG}	V_5	a	a	a	a					0.3	0.8	3.0	V
Supply*1 current	CXL1503M CXL1505M	I_{DD}	A_1	b	a	a	V_1				—	20	35	mA
Insertion gain	IG	V_6	b	b	a to d	a	$A, B_{ch} \rightarrow V_1$ $C, D_{ch} \rightarrow V_2 - 0.2V$	20 log $\frac{\text{Output amplitude (mVp-p)}}{\text{Input amplitude (SIN 100kHz, 100mVp-p)}}$			-4.5	-3.5	-0.5	dB
Frequency*1 response	CXL1503M CXL1505M	f_G	V_6	c	b	a to d	a	↓	20 log $\frac{\text{Output amplitude (SIN 1MHz, 100mVp-p)}}$ $\text{Output amplitude (SIN 100kHz, 100mVp-p)}$	-1.8	-0.8	—	dB	
Linearity	Lin.	V_6	b	b	a to d	a	↓	(Note 1)	(Note 2)	0	5	12	%	
Insertion gain difference between channels	ΔG									0	5	15	%	
Linearity difference between channels	$A_{ch} \leftrightarrow B_{ch}$ $C_{ch} \leftrightarrow D_{ch}$	ΔLAB ΔLCD						(Note 3)	(Note 3)	0	1	5	%	
Cross talk between channels	CRT	V_6	a	b	a to d	a ↔ b	$A, B_{ch} \rightarrow V_1$ $C, D_{ch} \rightarrow V_2 - 0.2V$	(Note 4)	0	1	5	%		

*1 Standard values are different between CXL1503M and CXL1505M.

Notes)**1. Linearity testing**

For A channel and B channel, set input bias E₁ to ABCN + 0.2 [V] first, and then set it to ABCN [V] and ABCN – 0.2 [V]. Then input a sine wave of 100kHz and 100mVp-p, and compare the three output amplitudes.

For C channel and D channel, set input bias E₁ to ABBL – 0.4 [V] first, and then set it to ABBL – 0.2 [V] and ABBL [V]. Then input a sine wave of 100kHz and 100mVp-p, and compare the three output amplitudes.

The maximum output amplitude for the respective A, B, C and D channels is taken as Sout max. and the minimum output amplitude as Sout min. The linearity of the respective channels is defined as

$$Lin = \frac{Sout\ max - Sout\ min}{Sout\ max + Sout\ min} \times 200 [\%]$$

2. Calculation of insertion gain difference

As the max. insertion gain among A, B, C and D channels' is taken as Gmax and the min. as Gmin., the insertion gain difference between channels becomes:

$$\Delta G = ABS(1 - 10^{\left(\frac{G_{max} - G_{min}}{20}\right)}) \times 100 [\%]$$

3. Calculation of linearity difference

Define A channel linearity as L_A, and B channel linearity as L_B. We obtain the difference ΔL_{AB} as follows.

$$\Delta L_{AB} = | L_A - L_B | [\%]$$

Similarly we obtain the linearity difference ΔL_{CD} of C channel and D channel as follows.

$$\Delta L_{CD} = | L_C - L_D | [\%]$$

4. Crosstalk calculation

We take CRTa as: A channel crosstalk value only during B channel input

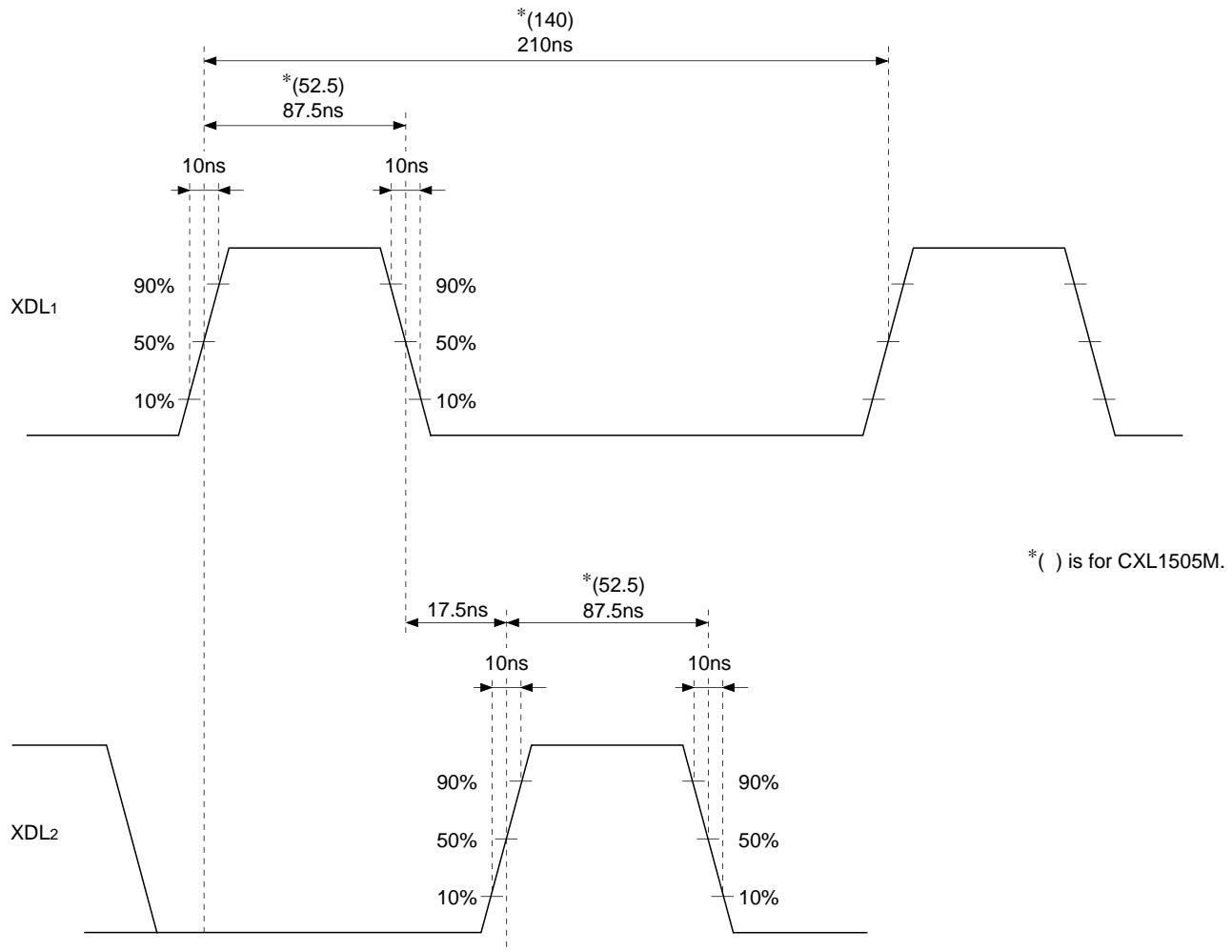
CRTb as: B channel crosstalk value only during A channel input

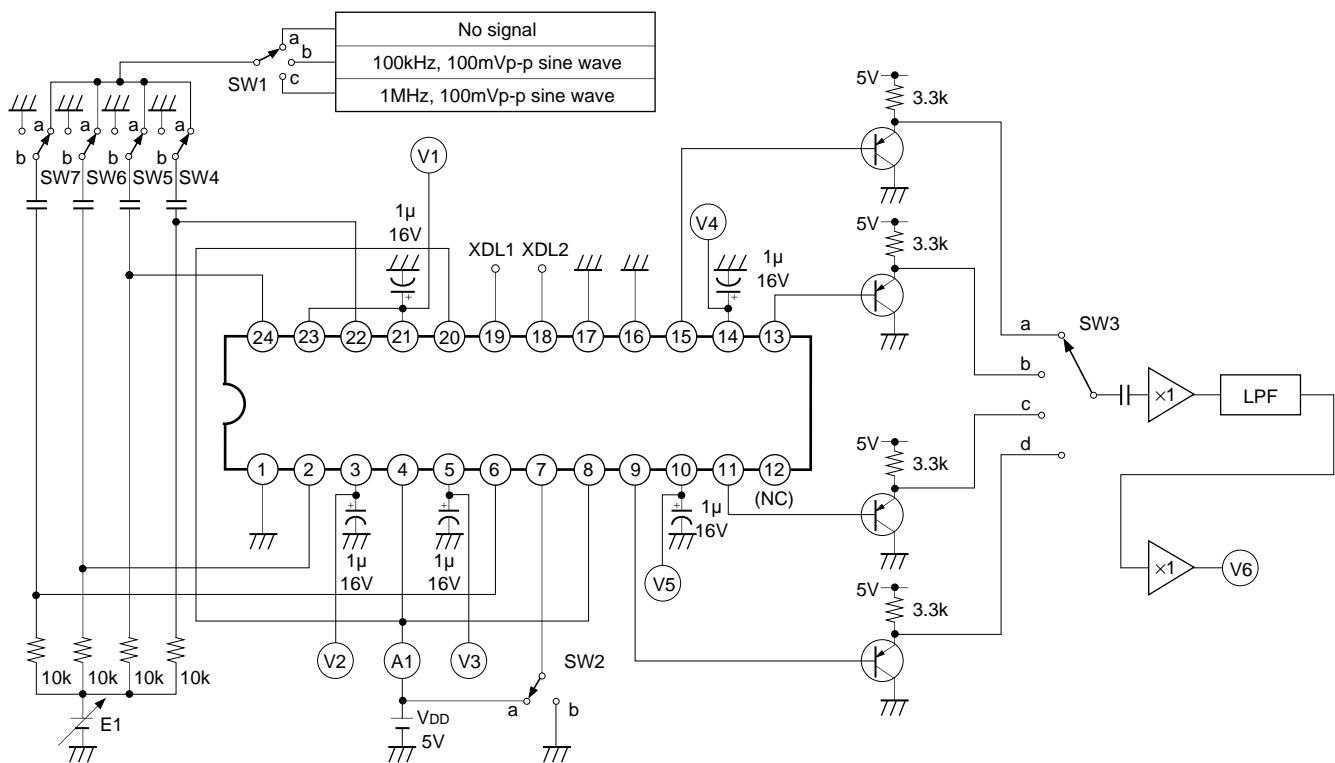
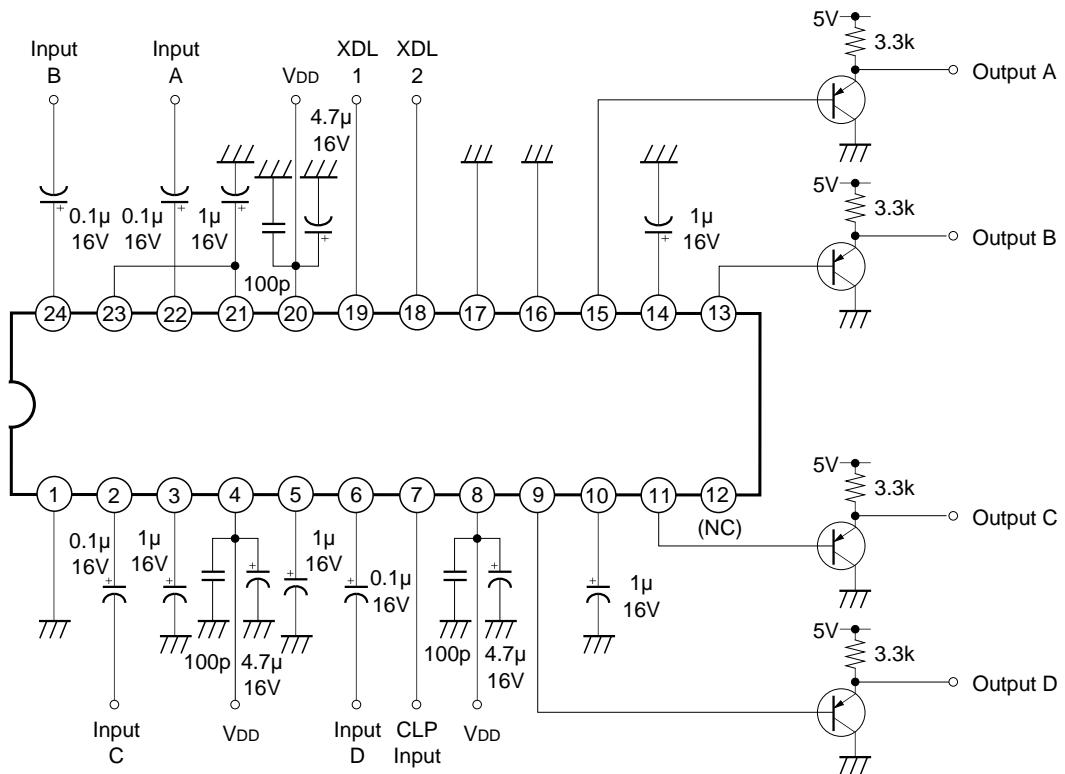
CRTC as: C channel crosstalk value only during D channel input

CRTd as: D channel crosstalk value only during C channel input

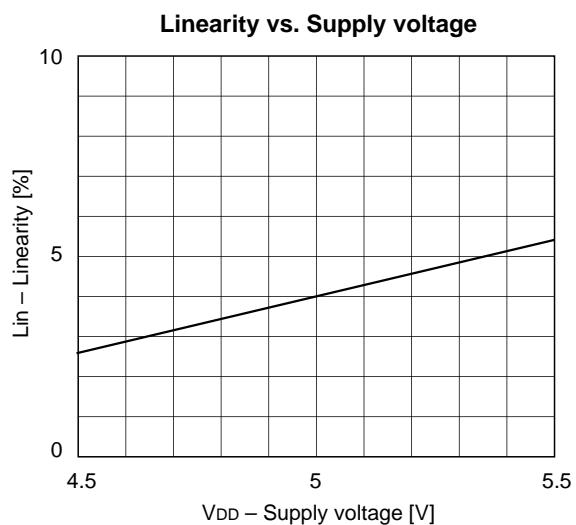
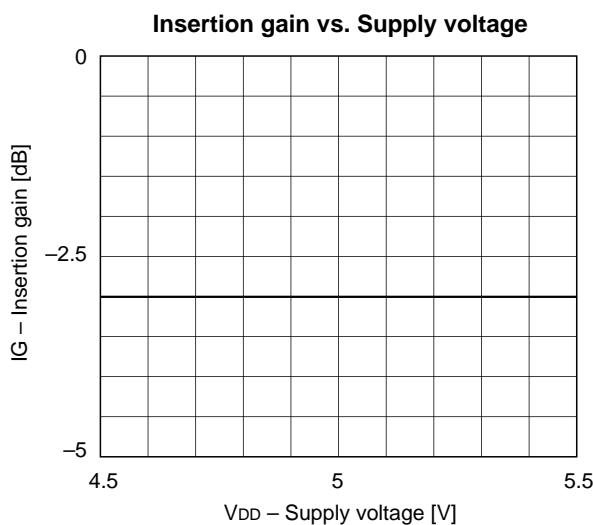
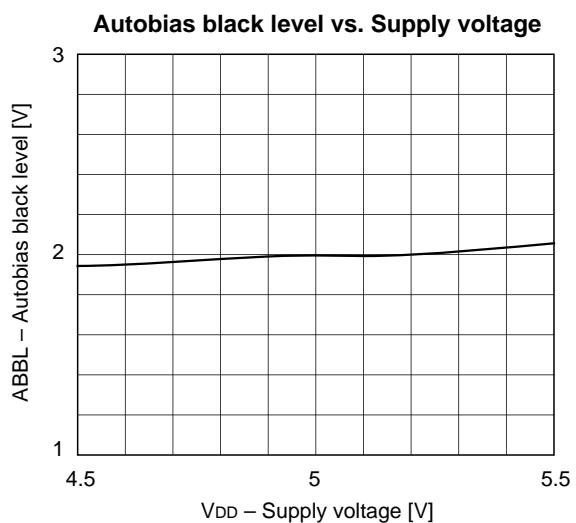
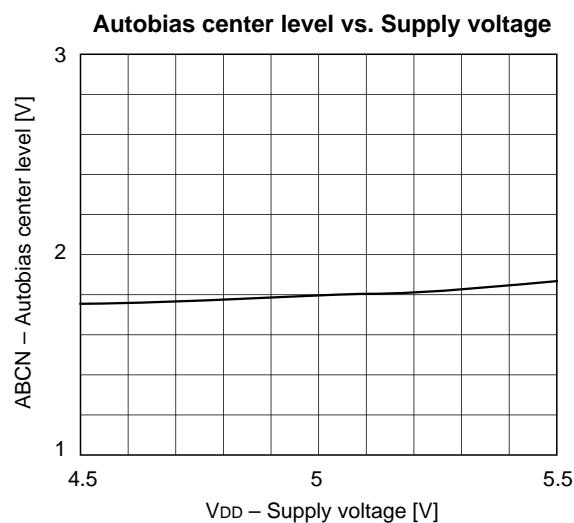
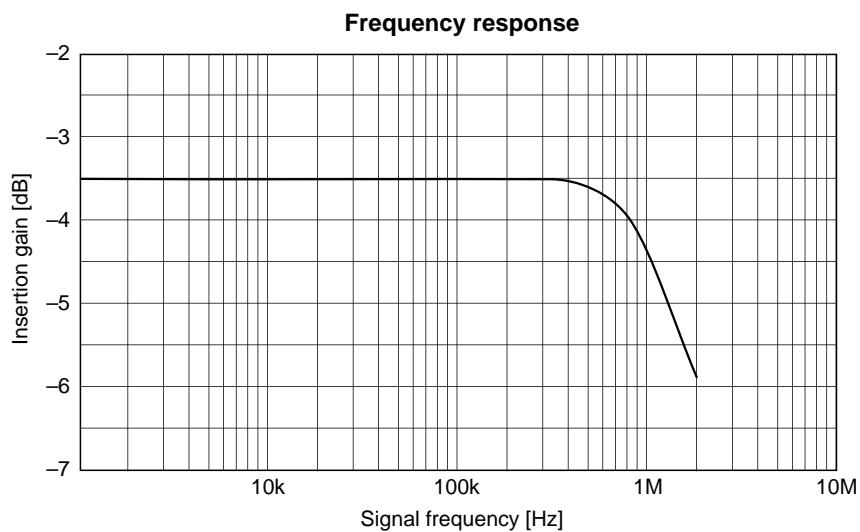
The crosstalk value of respective channels becomes:

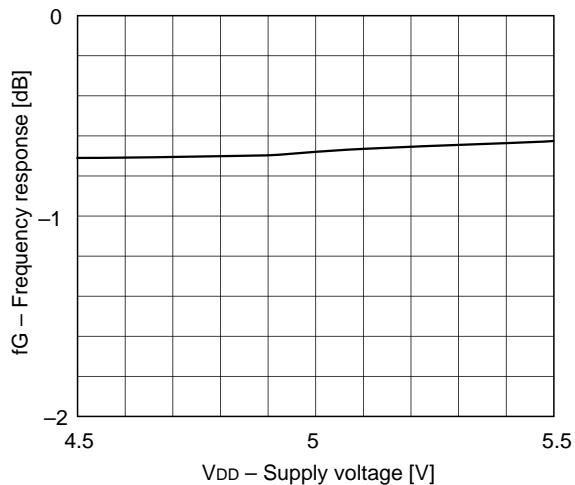
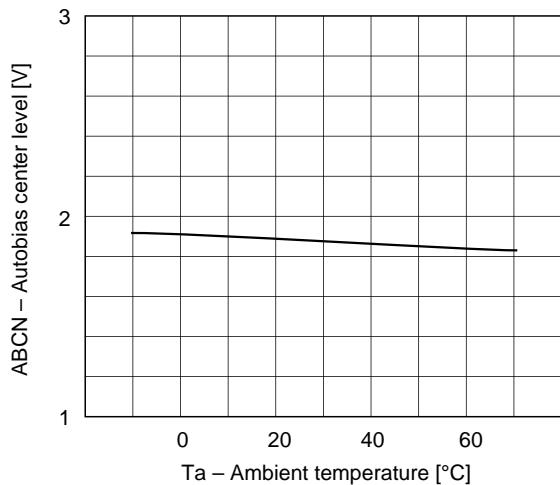
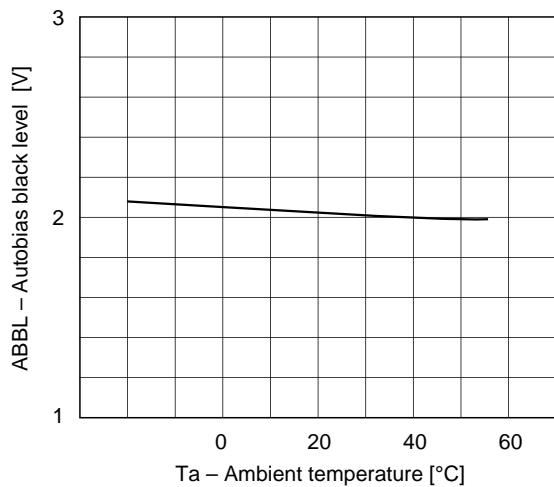
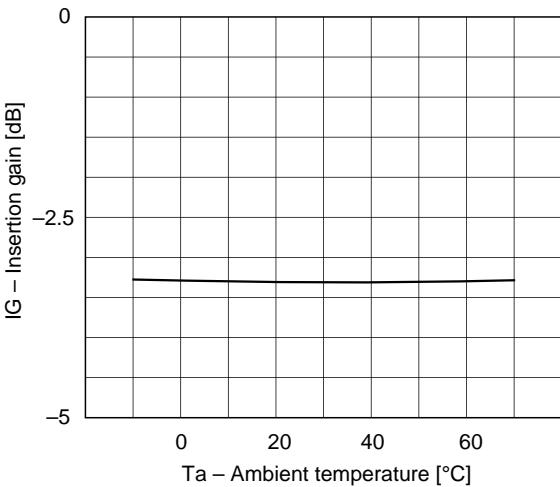
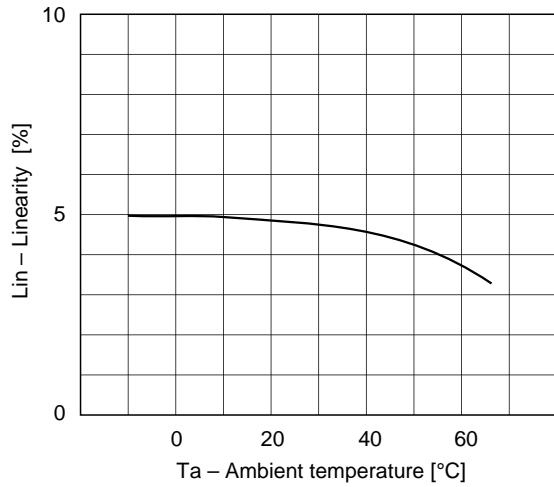
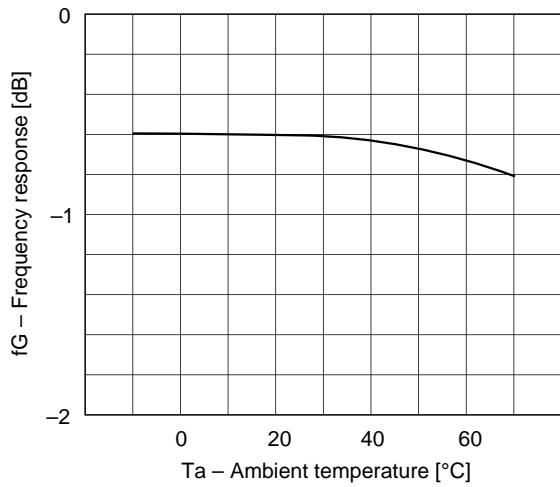
$$CRTa\ to\ d = \frac{\text{Crosstalk component}}{\text{Each channel output value}} \times 100 [\%]$$

Clock Waveform Timing

Electrical Characteristics Test Circuit**Application Circuit**

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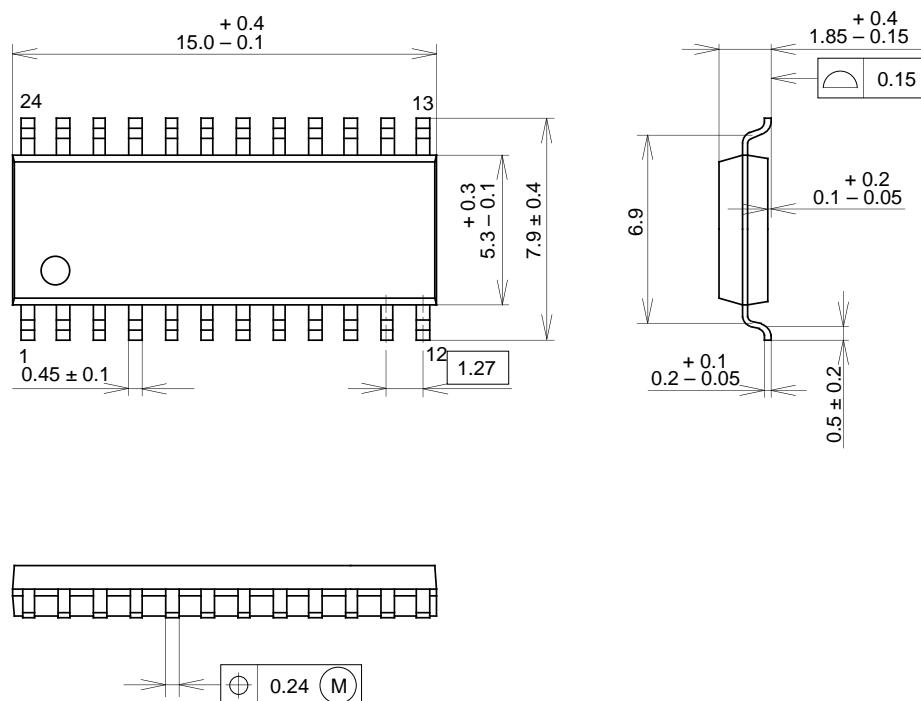


Frequency response vs. Supply voltage**Autobias center level vs. Ambient temperature****Autobias black level vs. Ambient temperature****Insertion gain vs. Ambient temperature****Linearity vs. Ambient temperature****Frequency response vs. Ambient temperature**

Package Outline

Unit: mm

24PIN SOP (PLASTIC)

**PACKAGE STRUCTURE**

SONY CODE	SOP-24P-L01
EIAJ CODE	SOP024-P-0300
JEDEC CODE	-----

MOLDING COMPOUND	EPOXY RESIN
LEAD TREATMENT	SOLDER PLATING
LEAD MATERIAL	42/COPPER ALLOY
PACKAGE MASS	0.3g